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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/660,603	KANEKO ET AL.	
Examiner	Art Unit	
Lincoln Donovan	2832	

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SEARCHED					
Class	Subclass	Date	Examiner		
336	83, 90-98 192 198	12/4/2004	LD		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Tuyen Nguyen	12/4/2004	LD	